## WE CLAIM:

- 1. A giant magnetoresistive memory device
  2 comprising:
- 3 a magnetic storage layer;
- 4 a magnetic sense layer;
- 5 a non-magnetic spacer layer between the
- 6 magnetic sense layer and the magnetic storage layer; and,
- 7 an antiferromagnetic layer formed in proximity
- 8 to the magnetic storage layer whereby the
- 9 antiferromagnetic layer couples magnetically in a
- 10 controlled manner to the magnetic storage layer such that
- 11 the magnetic storage layer has uniform and/or directional
- 12 magnetization.
- 1 2. The giant magnetoresistive memory device
- 2 of claim 1 wherein the magnetic storage layer comprises a
- 3 ferromagnetic alloy.
- 1 3. The giant magnetoresistive memory device
- 2 of claim 1 wherein the magnetic storage layer comprises
- 3 ferromagnetic multilayers.

- 1 4. The giant magnetoresistive memory device
- 2 of claim 1 wherein the storage layer is between the non-
- 3 magnetic spacer layer and the antiferromagnetic layer,
- 4 and wherein the non-magnetic spacer layer is between the
- 5 storage layer and the sense layer.
- 1 5. The giant magnetoresistive memory device
- 2 of claim 4 wherein the magnetic storage layer comprises a
- 3 ferromagnetic alloy.
- 1 6. The giant magnetoresistive memory device
- 2 of claim 4 wherein the magnetic storage layer comprises
- 3 ferromagnetic multilayers.
- 1 7. The giant magnetoresistive memory device
- 2 of claim 1 wherein the antiferromagnetic layer is between
- 3 the non-magnetic spacer layer and the storage layer, and
- 4 wherein the non-magnetic spacer layer is between the
- 5 antiferromagnetic layer and the sense layer.
- 1 8. The giant magnetoresistive memory device
- 2 of claim 7 wherein the magnetic storage layer comprises a
- 3 ferromagnetic alloy.

- 1 9. The giant magnetoresistive memory device
- 2 of claim 7 wherein the magnetic storage layer comprises
- 3 ferromagnetic multilayers.
- 1 10. The giant magnetoresistive memory device
- 2 of claim 1 wherein the antiferromagnetic layer comprises
- 3 a first antiferromagnetic layer, wherein the giant
- 4 magnetoresistive memory device comprises a second
- 5 antiferromagnetic layer, wherein the storage layer is
- 6 between the first and second antiferromagnetic layers,
- 7 wherein the second antiferromagnetic layer is between the
- 8 non-magnetic spacer layer and the storage layer, and
- 9 wherein the non-magnetic spacer layer is between the
- 10 second antiferromagnetic layer and the sense layer.
- 1 11. The giant magnetoresistive memory device
- 2 of claim 10 wherein the magnetic storage layer comprises
- 3 a ferromagnetic alloy.
- 1 12. The giant magnetoresistive memory device
- 2 of claim 10 wherein the magnetic storage layer comprises
- 3 ferromagnetic multilayers.

- 1 13. A giant magnetoresistive memory device 2 comprising: a magnetic storage layer; 3 a magnetic sense layer; 4 a non-magnetic spacer layer between the 5 6 magnetic sense layer and the magnetic storage layer; 7 a first antiferromagnetic layer formed in proximity to the magnetic storage layer whereby the first 8 antiferromagnetic layer couples magnetically in a 9 controlled manner to the magnetic storage layer such that 10 the magnetic storage layer has uniform and/or directional 11 12 magnetization; and, a second antiferromagnetic layer formed in 13 proximity to the magnetic sense layer whereby the second 14 antiferromagnetic layer couples magnetically in a 15 controlled manner to the magnetic sense layer such that 16 the magnetic sense layer has uniform and/or directional 17 18 magnetization.
- 1 14. The giant magnetoresistive memory device 2 of claim 13 wherein the magnetic storage layer comprises 3 a ferromagnetic alloy.

- 1 15. The giant magnetoresistive memory device
- 2 of claim 13 wherein the magnetic storage layer comprises
- 3 ferromagnetic multilayers.
- 1 16. The giant magnetoresistive memory device
- 2 of claim 13 wherein the magnetic sense layer comprises a
- 3 ferromagnetic alloy.
- 1 17. The giant magnetoresistive memory device
- 2 of claim 13 wherein the magnetic sense layer comprises
- 3 ferromagnetic multilayers.
- 1 18. The giant magnetoresistive memory device
- 2 of claim 13 wherein the magnetic sense layer comprises a
- 3 first ferromagnetic alloy, and wherein the magnetic
- 4 storage layer comprises a second ferromagnetic alloy.
- 1 19. The giant magnetoresistive memory device
- 2 of claim 13 wherein the magnetic sense layer comprises
- 3 first ferromagnetic multilayers, and wherein the magnetic
- 4 storage layer comprises second ferromagnetic multilayers.

- 1 20. The giant magnetoresistive memory device
- 2 of claim 13 wherein the storage layer is between the non-
- 3 magnetic spacer layer and the first antiferromagnetic
- 4 layer, and wherein the sense layer is between the non-
- 5 magnetic spacer layer and the second antiferromagnetic
- 6 layer.
- 1 21. The giant magnetoresistive memory device
- 2 of claim 13 wherein the storage layer is between the non-
- 3 magnetic spacer layer and the first antiferromagnetic
- 4 layer, and wherein the second antiferromagnetic layer is
- 5 between the sense layer and the non-magnetic spacer
- 6 layer.
- 1 22. The giant magnetoresistive memory device
- 2 of claim 13 wherein the first antiferromagnetic layer is
- 3 between the storage layer and the non-magnetic spacer
- 4 layer, and wherein the sense layer is between the second
- 5 antiferromagnetic layer and the non-magnetic spacer
- 6 layer.

- 1 23. The giant magnetoresistive memory device
- 2 of claim 13 wherein the first antiferromagnetic layer is
- 3 between the storage layer and the non-magnetic spacer
- 4 layer, and wherein the second antiferromagnetic layer is
- 5 between the sense layer and the non-magnetic spacer
- 6 layer.
- 1 24. The giant magnetoresistive memory device
- 2 of claim 13 wherein the first antiferromagnetic layer
- 3 comprises first and second storage antiferromagnetic
- 4 layers, wherein the second antiferromagnetic layer
- 5 comprises first and second sense antiferromagnetic
- 6 layers, wherein the storage layer is between the first
- 7 and second storage antiferromagnetic layers, wherein the
- 8 second storage antiferromagnetic layer is between the
- 9 storage layer and the non-magnetic spacer layer, wherein
- 10 the sense layer is between the first and second sense
- 11 antiferromagnetic layers, and wherein the second sense
- 12 antiferromagnetic layer is between the sense layer and
- 13 the non-magnetic spacer layer.

- 1 25. The giant magnetoresistive memory device
- 2 of claim 24 wherein the second storage antiferromagnetic
- 3 layer is thinner that the first storage antiferromagnetic
- 4 layer.
- 1 26. The giant magnetoresistive memory device
- 2 of claim 24 wherein the second sense antiferromagnetic
- 3 layer is thinner that the first sense antiferromagnetic
- 4 layer.
- 1 27. The giant magnetoresistive memory device
- 2 of claim 26 wherein the second storage antiferromagnetic
- 3 layer is thinner that the first storage antiferromagnetic
- 4 layer.
- 1 28. A method of fabricating a giant
- 2 magnetoresistive memory device comprising:
- forming a non-magnetic spacer layer between a
- 4 magnetic sense layer and a magnetic storage layer; and,
- forming an antiferromagnetic layer in proximity
- 6 to one of the magnetic storage layer and the magnetic
- 7 sense layer whereby the antiferromagnetic layer couples
- 8 magnetically in a controlled manner to the one of the
- 9 magnetic storage layer and the magnetic sense layer such

- 10 that the one of the magnetic storage layer and the
- 11 magnetic sense layer has uniform and/or directional
- 12 magnetization.
- 1 29. The method of claim 28 wherein the
- 2 magnetic storage layer comprises a ferromagnetic alloy.
- 1 30. The method of claim 28 wherein the
- 2 magnetic storage layer comprises ferromagnetic
- 3 multilayers.
- 1 31. The method of claim 28 wherein the
- 2 magnetic sense layer comprises a ferromagnetic alloy.
- 1 32. The method of claim 28 wherein the
- 2 magnetic sense layer comprises ferromagnetic multilayers.
- 1 33. The method of claim 28 wherein the
- 2 magnetic sense layer comprises a first ferromagnetic
- 3 alloy, and wherein the magnetic storage layer comprises a
- 4 second ferromagnetic alloy.

- 1 34. The method of claim 28 wherein the
- 2 magnetic sense layer comprises first ferromagnetic
- 3 multilayers, and wherein the magnetic storage layer
- 4 comprises second ferromagnetic multilayers.
- 1 35. The method of claim 28 wherein the forming
- 2 of a non-magnetic spacer layer between a magnetic sense
- 3 layer and a magnetic storage layer comprises forming a
- 4 non-magnetic spacer layer between a ferromagnetic storage
- 5 layer and a ferromagnetic sense layer.
- 1 36. The method of claim 28 wherein the forming
- 2 of an antiferromagnetic layer in proximity to one of the
- 3 magnetic storage layer and the magnetic sense layer
- 4 comprises forming the antiferromagnetic layer between the
- 5 magnetic storage layer and the non-magnetic spacer layer.
- 1 37. The method of claim 28 wherein the forming
- 2 of an antiferromagnetic layer in proximity to one of the
- 3 magnetic storage layer and the magnetic sense layer
- 4 comprises forming the antiferromagnetic layer so that the
- 5 magnetic storage layer is between the antiferromagnetic
- 6 layer and the non-magnetic spacer layer.

- 1 38. The method of claim 28 wherein the forming
- 2 of an antiferromagnetic layer in proximity to one of the
- 3 magnetic storage layer and the magnetic sense layer
- 4 comprises:
- forming a first antiferromagnetic layer in
- 6 proximity to the magnetic storage layer; and,
- 7 forming a second antiferromagnetic layer in
- 8 proximity to the magnetic sense layer.
- 1 39. The method of claim 38 wherein the forming
- 2 of a non-magnetic spacer layer between a magnetic sense
- 3 layer and a magnetic storage layer comprises forming a
- 4 non-magnetic spacer layer between a ferromagnetic storage
- 5 layer and a ferromagnetic sense layer.
- 1 40. The method of claim 38 wherein the forming
- 2 of a first antiferromagnetic layer in proximity to the
- 3 magnetic storage layer comprises forming the first
- 4 antiferromagnetic layer so that the storage layer is
- 5 between the non-magnetic spacer layer and the first
- 6 antiferromagnetic layer, and wherein the forming of a
- 7 second antiferromagnetic layer in proximity to the
- 8 magnetic sense layer comprises forming the second
- 9 antiferromagnetic layer so that the sense layer is

- 10 between the non-magnetic spacer layer and the second
- 11 antiferromagnetic layer.
- 1 41. The method of claim 38 wherein the forming
- 2 of a first antiferromagnetic layer in proximity to the
- 3 magnetic storage layer comprises forming the first
- 4 antiferromagnetic layer so that the storage layer is
- 5 between the non-magnetic spacer layer and the first
- 6 antiferromagnetic layer, and wherein the forming of a
- 7 second antiferromagnetic layer in proximity to the
- 8 magnetic sense layer comprises forming the second
- 9 antiferromagnetic layer so that the second
- 10 antiferromagnetic layer is between the sense layer and
- 11 the non-magnetic spacer layer.
- 1 42. The method of claim 38 wherein the forming
- 2 of a first antiferromagnetic layer in proximity to the
- 3 magnetic storage layer comprises forming the first
- 4 antiferromagnetic layer so that the first
- 5 antiferromagnetic layer is between the storage layer and
- 6 the non-magnetic spacer layer, and wherein the forming of
- 7 a second antiferromagnetic layer in proximity to the
- 8 magnetic sense layer comprises forming the second
- 9 antiferromagnetic layer so that the sense layer is

- 10 between the second antiferromagnetic layer and the non-
- 11 magnetic spacer layer.
- 1 43. The method of claim 38 wherein the forming
- 2 of a first antiferromagnetic layer in proximity to the
- 3 magnetic storage layer comprises forming the first
- 4 antiferromagnetic layer so that the first
- 5 antiferromagnetic layer is between the storage layer and
- 6 the non-magnetic spacer layer, and wherein the forming of
- 7 a second antiferromagnetic layer in proximity to the
- 8 magnetic sense layer comprises forming the second
- 9 antiferromagnetic layer so that the second
- 10 antiferromagnetic layer is between the sense layer and
- 11 the non-magnetic spacer layer.
- 1 44. The method of claim 38 wherein the forming
- 2 of a first antiferromagnetic layer in proximity to the
- 3 magnetic storage layer comprises forming first and second
- 4 storage antiferromagnetic layers in proximity to the
- 5 magnetic storage layer, wherein the forming of a second
- 6 antiferromagnetic layer in proximity to the magnetic
- 7 sense layer comprises forming first and second sense
- 8 antiferromagnetic layers in proximity to the magnetic
- 9 sense layer, wherein the storage layer is between the

- 10 first and second storage antiferromagnetic layers,
- 11 wherein the second storage antiferromagnetic layer is
- 12 between the storage layer and the non-magnetic spacer
- 13 layer, wherein the sense layer is between the first and
- 14 second sense antiferromagnetic layers, and wherein the
- 15 second sense antiferromagnetic layer is between the sense
- 16 layer and the non-magnetic spacer layer.
- 1 45. The method of claim 44 wherein the second
- 2 storage antiferromagnetic layer is thinner that the first
- 3 storage antiferromagnetic layer.
- 1 46. The method of claim 44 wherein the second
- 2 sense antiferromagnetic layer is thinner that the first
- 3 sense antiferromagnetic layer.
- 1 47. The method of claim 46 wherein the second
- 2 storage antiferromagnetic layer is thinner that the first
- 3 storage antiferromagnetic layer.